



Test report No:
21B0620R -RF-U-P20V01

FCC Exposure Evaluation Declaration

Product Name	BCM-KEY
Trademark	SGMW
Model and /or type reference	RKE3.1
FCC ID	2AVYXRKE31
Applicant's name / address	SAIC GM WULING AUTOMOBILE COMPANY LIMITED Liuzhou City, Guangxi Zhuang Autonomous Region, 545007 China
Test method requested, standard	KDB 447498D01V06 FCC Part1.1310
Verdict Summary	IN COMPLIANCE
Testedby (name / position & signature)	Adma Lu/Project Engineer <i>Adma Lu</i>
Approved by (name / position & signature)	Jack Zhang/Supervisor <i>Jack Zhang</i>
Date of issue	2022-03-08
Report template No	Template_KDB 447498_MPE-RF-V1.0

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COMPETENCES AND GUARANTEES

DEKRA is a testing laboratory competent to carry out the tests described in this report.

In order to assure the traceability to other national and international laboratories, DEKRA has a calibration and maintenance program for its measurement equipment.

DEKRA guarantees the reliability of the data presented in this report, which is the result of the measurements and the tests performed to the item under test on the date and under the conditions stated in the report and it is based on the knowledge and technical facilities available at DEKRA at the time of performance of the test.

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The results presented in this Test Report apply only to the particular item under test established in this document.

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GENERAL CONDITIONS

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3. This document is only valid if complete; no partial reproduction can be made without previous written permission of DEKRA.
4. This test report cannot be used partially or in full for publicity and/or promotional purposes without previous written permission of DEKRA.

ENVIRONMENTAL CONDITIONS

The climatic conditions during the tests are within the limits specified by the manufacturer for the operation of the EUT and the test equipment. The climatic conditions during the tests were within the following limits:

Ambient temperature	15 °C – 35 °C
Relative Humidity air	30% - 60%

If explicitly required in the basic standard or applied product / product family standard the climatic values are recorded and documented separately in this test report.

POSSIBLE TEST CASE VERDICTS

Test case does not apply to test object	N/A
Test object does meet requirement	P (Pass) / PASS
Test object does not meet requirement	F (Fail) / FAIL
Not measured	N/M

ABBREVIATIONS

For the purposes of the present document, the following abbreviations apply:

EUT	: Equipment Under Test
QP	: Quasi-Peak
CAV	: CISPR Average
AV	: Average
CDN	: Coupling Decoupling Network
SAC	: Semi-Anechoic Chamber
OATS	: Open Area Test Site
BW	: Bandwidth
AM	: Amplitude Modulation
PM	: Pulse Modulation
HCP	: Horizontal Coupling Plane
VCP	: Vertical Coupling Plane
U_N	: Nominal voltage
T_x	: Transmitter
R_x	: Receiver
N/A	: Not Applicable
N/M	: Not Measured

DOCUMENT HISTORY

Report No.	Version	Description	Issued Date
21B0620R-RF-US-P20V01	V1.0	Initial issue of report.	2022-03-08

REMARKS AND COMMENTS

1. The equipment under test (EUT) does meet the essential requirements of the stated standard(s)/test(s).
2. These test results on a sample of the device are for the purpose of demonstrating Compliance with KDB 447498 and FCC Part 1.1310
3. The measurement result is considered in conformance with the requirement if it is within the prescribed limit, It is not necessary to account the uncertainty associated with the measurement result, unless the specification, standard or customer have special requirements
4. The test results relate only to the samples tested.
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1. RF Exposure Evaluation

1.1. Limits

According to **KDB 447498 D01 General RF Exposure Guidance v06**

4.3.1 Standalone SAR test exclusion considerations

1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

$$[(\text{max. power of channel, including tune-up tolerance, mW})/(\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}] \leq 3.0$$

for 1-g SAR and ≤ 7.5 for 10-g extremity SAR, where

- $f(\text{GHz})$ is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison
- 3.0 and 7.5 are referred to as the numeric thresholds in the step 2 below

The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm according to 5) in section 4.1 is applied to determine SAR test exclusion.

2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following, and as illustrated in Appendix B:

- a) [Power allowed at numeric threshold for 50 mm in step 1) + (test separation distance - 50 mm) · (f(MHz)/150)] mW, at 100 MHz to 1500 MHz
- b) [Power allowed at numeric threshold for 50 mm in step 1) + (test separation distance - 50 mm) · 10] mW at > 1500 MHz and ≤ 6 GHz

3) The 1-g and 10-g SAR test exclusion thresholds for below 100 MHz at test separation distances ≤ 50 mm are determined by:

- a) The power threshold at the corresponding test separation distance at 100 MHz in step 2) is multiplied by $[1 + \log(100/f(\text{MHz}))]$ for test separation distances > 50 mm and < 200 mm
- b) The power threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$ for test separation distances ≤ 50 mm
- c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable. Note: when the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

1.2. Test Procedure

Software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel individually.

The temperature and related humidity: 18°C and 78% RH.

1.3. Test Result of RF Exposure Evaluation

Product	:	BCM-KEY
Test Item	:	RF Exposure Evaluation
Test Site	:	AC-6

Power Density

Band	Exposure Condition	Pmax	Pmax	Distance	f(GHz)	calculation result	Stand-alone Test exclusion threshold	SAR Test
		(dBm)	(mw)	(mm)				
RFID	Body	-21.179	1	5	433.92	0.00002	0.29	No

Note:

Conclusion: 433.92MHz SAR was not required.

_____ The End _____